## IBM Research Report

## Overlap Matching

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# Overlap Matching 

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#### Abstract

We propose a new paradigm for string matching, namely structural matching. In structural matching, the text and pattern contents are not important. Rather, some areas in the text and patterns are singled out, say intervals. A "match" is a text location where a specified relation between the text and pattern areas is satisfied.

In particular we define the structural matching problem of Overlap (Parity) Matching. We seek the text locations where all overlaps of the given pattern and text intervals have even length. We show that this problem can be solved in time $O(n \log m)$, where the text length is $n$ and the pattern length is $m$.

As an application of overlap matching, we show how to reduce the String Matching with Swaps problem to the overlap matching problem. The String Matching with Swaps problem is the problem of string matching in the presence of local swaps. The best known deterministic upper bound for this problem was $O\left(n m^{1 / 3} \log m \log \sigma\right)$ for a general alphabet $\Sigma$, where $\sigma=$ $\min (m,|\Sigma|)$.

Our reduction provides a solution to the pattern matching with swaps problem in time $O(n \log m \log \sigma)$.


## 1 Introduction

The last few decades have prompted the evolution of pattern matching from a combinatorial solution of the exact string matching problem $[12,16]$ to an area concerned with approximate matching of various relationships motivated by computational molecular biology, computer vision, and complex searches in digitized and distributed multimedia libraries [11, 7]. To this end, two new paradigms were needed - "Generalized matching" and "Approximate matching".

In generalized matching the input is still a text and pattern but the "matching" relation is defined differently. The output is all locations in the text where the pattern "matches" under the new definition of match. The different applications define the matching relation. Examples are string matching with "don't cares" [12], parameterized matching [8, 4], less-than matching [3], and swapped matching [21, 2, 9]. Lower bound results on generalized matching can be found in [22].

Even under the appropriate matching relation there is still a distinction between exact matching and approximate matching. In the latter case, a distance function is defined on the text. A text location

[^0]is considered a match if the distance between it and the pattern, under the given distance function, is within the tolerated bounds. Below are some examples that motivate approximate matching. In computational biology one may be interested in finding a "close" mutation, in communications one may want to adjust for transmission noise, in texts it may be desirable to allow common typing errors. In multimedia one may want to adjust for lossy compressions, occlusions, scaling, affine transformations or dimension loss.

The earliest and best known distance functions are Levenshtein's edit distance [19] and the Hamming distance. Let $n$ be the text length and $m$ the pattern length. Lowrance and Wagner [20, 24] proposed an $O(n m)$ dynamic programming algorithm for the extended edit distance problem. In [13, 17, 18] $O(k n)$ algorithms are given for the edit distance with only $k$ allowed edit operations. Recently, Cole and Hariharan [10] presented an $O\left(n k^{4} / m+n+m\right)$ algorithm for this problem. Amir, Lewenstein and Porat [6] presented faster algorithms for the Hamming distance case.

Both above paradigms have an important trait in common - matching is dependent on the alphabet symbols in the respective pattern and text locations. In this paper we propose a new paradigm Structural Matching. In this model, the content of the pattern and text is not important. What is important is the structure of these strings. Certain areas in the text and pattern are identified and a "match" of the pattern in the text is a location where these special areas satisfy a required relation. Structural Matching is motivated by two reasons. The first one is an "end" and the second one is a "means".

In molecular biology, it has long been a practice to consider special areas by their structure. Examples are repetitive genomic structures [14] such as tandem repeates, LINEs (Long Interspersed Nuclear Sequences) and SINEs (Short Interspersed Nuclear Sequences) [15]. Many problems in biology can be expressed as structural matching problems, thus streamlining and identifying the combinatorial nature of the problem.

The second reason is a functional one. The rich repertoire of relations between areas in the text and pattern can offer interesting tools for the solution of hitherto unresolved problems. In this paper we demonstrate such a use of structural matching for providing the fastest known algorithm for swap matching.

The Pattern Matching with Swaps problem (the Swap Matching problem, for short), defined by Muthukrishnan [21], requires finding all occurrences of a pattern of length $m$ in a text of length $n$. The pattern is said to match the text at a given location $i$ if adjacent pattern characters can be swapped, if necessary, so as to make the pattern identical to the substring of the text starting at location $i$. All the swaps are constrained to be disjoint, i.e., each character is involved in at most one swap.

The importance of the swap matching problem lies in recent efforts to understand the complexity of various generalized pattern matching problems. Until recently there were no known upper bounds better than the naive $O(n m)$ algorithm for the swap matching problem.

Amir et al [2] obtained the first non-trivial results on this problem. They showed that the case when the size of the alphabet set $\Sigma$ exceeds 2 can be reduced to the case when it is exactly 2 with a time overhead of $O\left(\log ^{2} \sigma\right)$. (The reduction overhead was reduced to $O(\log \sigma)$ in the journal version [1].) They then showed how to solve the problem for alphabet sets of size 2 in time $O\left(\mathrm{~nm}^{1 / 3} \log m\right)$, which is the best deterministic time bound known to date. Amir et al. [5] also give certain special cases for which $O(m$ polylog $(m))$ time can be obtained. However, these cases are rather restrictive. In their

TR [9] Cole and Hariharan provide a first step toward the current result by giving a randomized algorithm that solves the swap matching problem over a binary alphabet in time $O(n \log n)$. We note that the technical report is now subsumed by this result.

In this paper we define a structural matching problem - the Overlap (Parity) Matching Problem as follows.
INPUT: Text $T$ of length $n$ with marked intervals (substrings), and pattern $P$ of length $m$ with marked intervals (substrings).
OUTPUT: The text locations $\ell$ for which all overlaps of the marked intervals of $T$ and marked intervals of $P$ have even-length overlap.

We present a deterministic algorithm that solves the overlap matching problem in time $O(n \log m)$.
We then reduce the swap matching problem over binary alphabet to the overlap parity problem. Coupled with the alphabet reduction of [1] it gives an algorithm for swap matching over general alphabet whose running time is $O(n \log m \log \sigma)$.

There are three main contributions in this paper.

1. The introduction of a new model in pattern matching, that of structural matching.
2. An efficient solution of the overlap matching problem.
3. The surprising time complexity of $O(n \log m)$ for solving the swap matching problem over binary alphabets. Until recently it was open whether the problem had a $o(n m)$ solution.

Roadmap. In section 2 we give basic definitions. In sections 3, 4, 5 and 6 we solve the overlap matching problem. In section 7 we define the swap matching problem. In section 8 we prove a key lemma and show how to utilize this lemma in order to reduce swap matching to overlap matching.

## 2 Problem Definition

Consider a linear structure composed of contiguous units, called segments. Each segment has an associated length. A segment can be either marked or unmarked. A structural string is a concatenation of (marked and unmarked) segments. See fig. 1 for an example.

Overlap Matching is defined as follows:
Input: A structural string, $P$, which we will call the pattern, of length $m$ units (i.e. the sum of the segment lengths), and a structural string, $T$, which we call the text, of length $n \geq m$ units.

Output: All text locations $k$, where, when $P$ is aligned to start at $k$, each pair of marked text segment-marked pattern segment that overlap have even-length overlap.

Alternatively, we can replace the even-length overlap requirement with an odd-length overlap requirement. Since this problem can be reduced to the even-length case without much difficulty, we will only consider the even-length case.

Another way to visualize the pattern and the text is as regular strings partitioned into "segments" with several segments marked. Thus we can consider $P$ to be $p_{1} p_{2} \ldots p_{m}$ and $T$ to be $t_{1} t_{2} \ldots t_{n}$, the usual way of viewing a pattern and a text in string matching. However, it must be noted that the Overlap Matching problem is a structural problem and not a character dependent problem,
whereas, the usual problems in string matching are character dependent rather than structural. Therefore, even though we use the standard string matching notation for $P$ and $T$ the individual characters are irrelevant to the problem.

We note that our current problem derives from a character-based string matching application, and as a result the unary encoding of lengths in our complexity measure is appropriate.

## 3 Algorithm Outline for Overlap Matching

At a given location the pattern matches when each overlap of marked segments is of even-length. Restated, we have the following property:

Overlap parity property: $P$ matches at location $i$ of $T$ iff, when $P$ is aligned at location $i$, no pair of (pattern, text) marked segments has odd-length overlap.

This allows us to consider pairs of marked segments separately. As soon as a pair is found with odd-length overlap, it immediately leads to the conclusion that there is no match in that location.

The main idea of the algorithm is to separate the marked segments of the text and pattern into a small number of groups. In each of these groups it will be possible to check for the overlap parity property in time $O(n \log m)$ using polynomial multiplications (which can be done in time $O(n \log m)$ using FFT in a model with word length $m$ bits). In the following sections we handle the different cases. Some of these cases necessitate new and creative uses of convolutions.

### 3.1 Grouping Text Segments by Parity of Starting and Ending Location

It will be important for us to know whether the marked segment we are dealing with starts at an odd or even text location. We also would like to know whether it ends at an odd or even text location. Consequently, we define new texts where each text has exactly those marked segments of a given start and end parity, with all other text elements defined as $\phi$ (don't care) and never contribute an error. (In the polynomial multiplication there will always be a 0 in these text locations.)

Definition: $T^{o o}$ is a string of length $n$ where for every location $i$, if $t_{i}$ is in a marked segment whose first element is in an odd location and whose last element is in an odd location, $T^{o o}[i]=1$. In all other locations $j, T^{o o}[j]=\phi$.

In a similar fashion define $T^{o e}, T^{e o}, T^{e e}$.

## Example:



Figure 1: An example text.

```
T Oo = \phi\phi11111\phi\phi\phi\phi\phi\phi\phi1111111 \phi\phi\phi\phi\phi\phi\phi
T}\mp@subsup{T}{}{ee}=\phi\phi\phi\phi\phi\phi\phi\phi\phi111\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi
T
T}\mp@subsup{T}{}{eo}=\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi\phi
```

Note that the segments of $T^{o o}$ are exactly the marked segments of $T$ that start and end at an odd location. Thus, it is clear that in every location where none of the above four text strings $\left(T^{o o}, T^{o e}, T^{e o}, T^{e e}\right)$ violate the parity property there is a match.

### 3.2 Grouping the Pattern Segments

The pattern segments are defined in exactly the same way as the text segments and we would like to group them in the same way. However, there is a difficulty here in "nailing down" the parity of a location, since the pattern is shifted and compared to every text location. However, since the only property we have used in our grouping was the parity of the text location, it is clear that in all the pattern alignments that start in odd locations, the parity of the start and end segment locations will be the same. Similarly, these parities will be the same for all pattern alignments that start in even text locations.

Thus we limit ourselves to two cases. The Odd Result Case and the Even Result Case. The Odd Result case is simply the pattern alignments starting in odd text locations. The Even Result case is pattern alignments starting in even text locations.

When we fix an alignment result case it is possible to define the parity of the starting and ending locations of each pattern segment. Thus we can get, for the odd result case, patterns $P O^{o o}, P O^{o e}, P O^{e o}$ and $P O^{e e}$. Similarly, for the even result case we consider patterns $P E^{o o}, P E^{o e}, P E^{e o}$ and $P E^{e e}$. We are now ready for the algorithm.

## Algorithm

```
for \(X=O, E\) do:
    for \(t i=o, e\) do
        for \(t j=o, e\) do
            for \(p i=o, e\) do
                for \(p i=o, e\) do
                    check Odd Overlap property for \(T^{t i, t j}\) and \(P X^{p i, p j}\)
                    \{ Note that when \(X=O\) we only consider the results in the odd text locations
                    and when \(X=E\) we only consider the results in the even text locations. \(\}\)
```

In the subsequent sections we will show how to implement the check for odd-length overlap (the forbidden property) for each of the cases in time $O(n \log m)$. The intrepid reader will realize that there are 32 cases to consider. Don't panic! Because of symmetry reasons, there are only three cases we need to describe. All others are similar.

The cases we describe are the following. First fix the result parity to the Odd Result case. It is clear that the the Even Result case is symmetric. Since we don't need the $X$ parameter in the algorithm, we will henceforth ignore it for the sake of a simpler notation. We are now down to the combinations $T^{t i, t j}$ and $P^{p i, p j}$. This gives us 16 cases. We will handle separately only the following three types of cases:

1. $T^{t i, t j}$ and $P^{p i, p j}$ where either $t i=p i$ or $t j=p j$. (This type covers 12 cases.) These situations are handled in section 4.
2. $T^{t i, t j}$ and $P^{p i, p j}$ where $t i, t j=o e$ and $p i, p j=e o$; or where $t i, t j=e o$ and $p i, p j=o e$. These
cases are handled in section 5 .
3. $T^{t i, t j}$ and $P^{p i, p j}$ where $t i, t j=o o$ and $p i, p j=e e$; or where $t i, t j=e e$ and $p i, p j=o o$. These cases are handled in section 6 .

## 4 Segments with Equal Parity Start

Consider the case $T^{t i, t j}$ and $P^{p i, p j}$ where $t i=p i$.

Observation 1 : For every two segments, $S_{t}$ in $T^{t i, t j}$, starting at location $x$ and $S_{p}$ in $P^{p i, p j,}$ starting at location $y,|x-y|$ is always even. See all possibilities in figure 2 below.


Figure 2: The cases of both text and pattern segments starting in locations with the same parity.
We are interested in the length of the segment overlaps (the shaded areas in figure 2). A segment overlap has odd length iff the property of lemma 2 holds. We now show a convolution for which the resulting value at location $i$ is 0 iff there does not exists an odd-length segment overlap.

The Convolution: Construct a pattern $P^{\prime}=p_{1}^{\prime} \cdots p_{m}^{\prime}$ where

$$
p_{i}^{\prime}= \begin{cases}0, & \text { if } P^{p i, p j}[i]=\phi \\ 1, & \text { otherwise }\end{cases}
$$

Construct a text $T^{\prime}=t_{1}^{\prime} \cdots t_{n}^{\prime}$ where every $\phi$ in $T^{t i, t j}$ is replaced by 0 ; and every segment in $T^{t i, t j}$ is replaced by an alternating segment of 1 and -1 , starting at 1 .

It is clear that for all cases where the starting location of a pattern segment is smaller than the starting location of a text segment the result of the convolution will be 1 if the length of the overlap is odd and 0 if it is even (since every text segment starts with a 1 and then alternates between -1 and 1). Because of observation 1 , even when the text segment starts at a smaller location than the pattern segment, the difference between the starting locations has even length. Therefore in the area of the overlap, the text starts with a 1 and alternates between -1 and 1 . Thus the convolution gives us the desired result.
This solves all eight cases of $T^{t i, t j}$ and $P^{p i, p j}$ where $t i=p i$. For the additional four cases where $t j=p j$ simply reverse the text and pattern and achieve the case considered above.

## 5 The Odd-Even Even-Odd Segments

Consider the case $T^{o e}$ and $P^{e o}$ (the case of $T^{e o}$ and $P^{o e}$ is symmetric).

Terminology: Let $S_{t}$ be a text segment whose starting location is $s_{1}$ and whose ending location is $f_{1}$. Let $S_{p}$ be a pattern segment being compared to the text at starting position $s_{2}$ and ending position $f_{2}$. If $s_{1}<s_{2}<f_{2}<f_{1}$ then we say that $S_{t}$ contains $S_{p}$. If $s_{2}<s_{1}<f_{1}<f_{2}$ then we say that $S_{p}$ contains $S_{t}$. If $s_{1}<s_{2}<f_{1}<f_{2}$ then we say that $S_{t}$ has a left overlap with $S_{p}$. If $s_{2}<s_{1}<f_{2}<f_{1}$ then we say that $S_{t}$ has a right overlap with $S_{p}$. We will sometimes refer to a left or right overlap as a side overlap.

Observation 2 : For every two segments, $S_{t}$ in $T^{o e}$ and $S_{p}$ in $P^{e o}$ if either $S_{p}$ is contained in $S_{t}$ or $S_{t}$ is contained in $S_{p}$ then the overlap is of even length. If the overlap is a left overlap or right overlap then it is of odd length. See all possibilities in figure 3 below.


Figure 3: The cases where the text segment starts at an odd location and ends at an even location; the pattern segment does the opposite.

The correctness of the observation is immediate. Segments of these types have even length thus if one contains the other the overlap is necessarily of even length. Conversely, in case of a left or right overlap then the overlap starting and ending locations have the same parity, making the length of the overlap odd.

We will now show a convolution where segments that are contained in each other contribute a 0 , and side overlaps contribute positive numbers. This convolution will be more complex than the previous one. The reason is that there is some inherent relation between text segments that start within a pattern segment. Likewise, there is a commonality between text segments that end within a pattern segment. Our problem is that we need to differentiate between cases that are naturally easier handled together.

Consider the following case. Let $S_{t}$ be a segment of $T^{o e}$ starting at text location $s_{1}$ and having length $\ell_{t}$. Assume that the pattern $P^{e o}$ of length $\ell_{p}$ is aligned to start at the text location such that the first symbol of segment $S_{p}$ occurs at location $s_{2}$. Further assume that one of the segments is contained in the other. If we replace $S_{t}$ by $s_{1} 1^{\ell_{t}-2}-s_{1}$ and $S_{p}$ by $s_{2} 1^{\ell_{p}-2}-s_{2}$ (and $\phi$ by 0 ) then multiplication of these two segments will yield $k-2$, where $k$ is the size of the overlap. See figure 4.


Multiplication: $\mathrm{S}_{1}+1_{1}-2-\mathrm{S}_{1}=1_{1}-2$

$\mathrm{S}_{2}+1_{2}-2-\mathrm{S}_{2}=1_{2}-2$

Figure 4: Containment cases for text $T^{o e}$ and pattern $P^{o e}$.
Conversely, if there is a side overlap of $S_{t}$ with $S_{p}$ then the multiplication will yield $\max \left(s_{1}, s_{2}\right)$ $\min \left(s_{1}, s_{2}\right)+k-2$, where $k$ is the size of the overlap. See figure 5 .


Figure 5: Edge intersection cases for text $T^{o e}$ and pattern $P^{e o}$.

If we could solve the following two problems, we are done.

1. Remove the size of the overlap -2 from the result. (This will make the multiplication result be 0 when all overlaps are containments.)
2. Be able to actually replace every segment by its starting point, 1 's and the negation of its starting point. (This will make the multiplication result positive when there exist side overlaps.) Being able to insert the starting point of the segment for the sake of multiplication is not at all simple to do since the same segment has $n-m$ different starting points!

However, if the above two problems could be solved by a convolution, then the result would be 0 iff all overlaps are containments iff all overlaps have even length (by observation 2).

In the Appendix, section 9.1, we show how to check both by using novel convolutions.

## 6 The Odd-Odd Even-Even Segments

Consider the case $T^{o o}$ and $P^{e e}$ (the case of $T^{e e}$ and $P^{o o}$ is symmetric).
Observation 3 : For every two segments, $S_{t}$ in $T^{o o}$ and $S_{p}$ in $P^{e e}$ if either $S_{p}$ is contained in $S_{t}$ or $S_{t}$ is contained in $S_{p}$ then the overlap is of odd length. If the overlap is a left overlap or right overlap then it is of even length. See all possibilities in figure 6 below.


Figure 6: Every containment has odd length; every side overlap has even length.
The correctness of the observation is immediate. Segments of these types have odd lengths thus if one contains the other the overlap is necessarily of odd length. Conversely, in case of a left or right overlap then the overlap starting and ending locations have the opposite parity, making the length of the overlap even.

Definition: Let $T$ be a text with segments $S t_{1}, \ldots, S t_{x}$ starting at locations $s_{1}, \ldots, s_{x}$, respectively. Let $P$ be a pattern such that, when placed at location $i_{0}$, its segments $S p_{1}, \ldots, S p_{y}$ start at locations
$v_{1}, \ldots, v_{y}$. Let $\left\{s_{i_{1}}, \ldots, s_{i_{z}}\right\}$ be the starting locations of text segments that have a left overlap with pattern segments or that contain a pattern segments, and let $\left\{v_{j_{1}}, \ldots, v_{j_{z}}\right\}$ be the starting location of the corresponding pattern segments. Similarly let $\left\{s_{k_{1}}, \ldots, s_{k_{w}}\right\}$ be the starting locations of text segments that have a right overlap with pattern segments or that are contained in pattern segments, and $\left\{v_{\ell_{1}}, \ldots, v_{\ell_{w}}\right\}$ be the starting locations of the corresponding pattern segments.

The external overlap length of the pattern at location $i_{0}$ is

$$
\sum_{r=1}^{y}\left(v_{i_{r}}-s_{j_{r}}\right)+\sum_{r=1}^{z}\left(s_{k_{r}}-v_{\ell_{r}}\right) .
$$

Note that unlike the external side length, containments also contribute to the external overlap length. See figure 7 for an illustration.


Figure 7: The sum of the shaded areas is the external overlap length:

$$
\left(v_{1}-s_{1}\right)+\left(v_{2}-s_{2}\right)+\left(v_{3}-s_{4}\right)+\left(s_{2}-v_{1}\right)+\left(s_{3}-v_{2}\right) .
$$

Note that $\left(s_{3}-v_{2}\right)+\left(v_{3}-s_{4}\right)$ would not be counted in the external side length.
We need a method to indicate whether there exist any overlaps. We will show that the external overlap length can be calculated by two convolutions. Since we know from section 5 how to compute the external side length, it suffices to see the difference between these two values. If it is 0 then there are no containments (and therefore no odd-length overlaps), otherwise there are containments.

The sum of the following two convolutions gives the external overlap length.
The External Contained and Right Length Convolution: Replace every segment of length $\ell$ in the pattern by $0123 \cdots \ell-1$, and every segment of length $\ell$ in the text by $10^{\ell-1}$. Replace every $\phi$ by 0 . Multiply.

The resulting value at every location $i_{0}$ is precisely the external length of the right overlaps and of the text segments contained in pattern segment overlaps. Left overlaps and text containing pattern give a 0 . The next convolution computes precisely the remaining external lengths.

The External Containing and Left Length Convolution: Replace every segment of length $\ell$ in the text by $0123 \cdots \ell-1$, and every segment of length $\ell$ in the pattern by $10^{\ell-1}$. Replace every $\phi$ by 0 . Multiply.
Adding the results of the above two convolutions gives the external overlap length.
Lemma 1 It is possible in time $O(n \log m)$ to provide, for every text location $i$, a value that is 0 if there are no containments either of text in pattern segments or of pattern in text segments, and positive otherwise.

Proof: Subtract the external side length from the external overlap length. If there is a containment, we will get a positive number, otherwise we get 0 .

## 7 Swap Matching

Definition: Let $S=s_{1} \ldots s_{n}$ be a string over alphabet $\Sigma$. A swap permutation for $S$ is a permutation $\pi:\{1, \ldots, n\} \rightarrow\{1, \ldots, n\}$ such that

1. if $\pi(i)=j$ then $\pi(j)=i$ (characters are swapped).
2. for all $i, \pi(i) \in\{i-1, i, i+1\}$ (only adjacent characters are swapped).
3. if $\pi(i) \neq i$ then $s_{\pi(i)} \neq s_{i}$ (identical characters are not swapped).

For a given string $S=s_{1} \ldots s_{n}$ and swap permutation $\pi$ for $S$ we denote $\pi(S)=s_{\pi(1)} s_{\pi(2)} \ldots s_{\pi(n)}$. We call $\pi(S)$ a swapped version of $S$.

For pattern $P=p_{1} \ldots p_{m}$ and text $T=t_{1} \ldots t_{n}$, we say that $P$ swap matches at location $i$ if there exists a swapped version $P^{\prime}$ of $P$ that matches $T$ starting at location $i$, i.e. $p_{j}^{\prime}=t_{i+j-1}$ for $j=1, \ldots, m$.

The Swap Matching Problem is the following:
INPUT: Pattern $P=p_{1} \ldots p_{m}$ and text $T=t_{1} \ldots t_{n}$ over alphabet $\Sigma$.
OUTPUT: All locations $i$ where $P$ swap matches $T$.
We note that the definition in [2] and the papers that followed is slightly different, allowing the swaps in the text rather than the pattern. However, it follows from Lemma 1 in [2] that both versions are of the same time complexity.

In general the alphabet $\Sigma$ can be very large, however this can be reduced to swap matching over a binary alphabet in $O(\log |\Sigma|)$ time. See Appendix, section 9.3.

## 8 Reducing Swap Matching to Overlap Matching

Following the reduction to a binary alphabet, we assume that the text and the pattern both have only $a$ 's and $b$ 's. An alternating segment of a string $S \in\{a, b\}^{*}$ is a substring alternating between $a s$ and $b s$. A maximal alternating segment, or segment for short, is an alternating segment such that the character to the left of the leftmost character $x$ in the alternating segment, if any, is identical to $x$, and similarly, the character to the right of the rightmost character $y$, if any, is identical to $y$.

We now show the key property necessary to reduce swap matching to overlap matching. To this end we partition the text and pattern into segments.

Lemma 2 The pattern does not match in a particular alignment if and only if there exists a segment $A$ in the text and a segment $B$ in the pattern such that (1) the characters of $A$ and $B$ misalign in the overlap and (2) the overlap is of odd-length.

Proof. In appendix, section 9.2.
Following Lemma 2, we would like to check each location whether there are overlapping segments with properties (1) and (2). To this end we will separate the segments of the text and pattern into two groups each, similar to what we did in the algorithm for the overlap matching.

We create these groups in such a way that the characters always misalign (property (1)) in the comparison of group vs. group. Moreover, the comparisons cover all possible misalignments of overlapping segments. Therefore, the necessary comparison is to check that the length of the overlap is odd (property (2)). We now describe the grouping.

### 8.1 Odd $a$ and Even $a$ Text Segments

The first two categories of text segments we consider are the Even a segments, where all the a's fall on even text locations, and the Odd a segments, where all the $a$ 's fall on odd text locations. We construct two new text (structural) strings, $T_{\text {odd-a }}$ and $T_{\text {even-a }}$, each of them having length $n$. $T_{o d d-a}$ is a text whose marked segments are all the odd $a$ segments of $T$ in their exact locations. The text locations where there are even $a$ segments are marked segments. Similarly, $T_{\text {even }-a}$ is the (structural) text string whose marked segments are all the even $a$ segments of $T$ in their exact locations and the other segments are unmarked. In fact $T_{\text {even-a }}$ and $T_{\text {odd-a }}$ complement each other in the sense that they are exactly the same strings where each marked segment in one is the unmarked in the other.

Example: Let $T=a b a b b b a a a b a b a b b a a b a b b a a a b a b a b a$.
The segments are: $a b a b b b a ~ a ~ a b a b a b ~ b a ~ a b a b ~ b a ~ a ~ a b a b a b a ~$
The odd $a$ segments are the first, third, fifth, seventh, and ninth. Thus
$T_{\text {odd-a }}=$ marked length 4, unmarked length 1, marked length 2, unmarked length 1, marked length 6 , unmarked length 2 , marked length 4, unmarked length 2, marked length 1 , unmarked length 7.

### 8.2 Odd $a$ and Even $a$ Pattern Segments

The pattern segments are defined in exactly the same way as the text segments and we would like to group them in the same way. However, as in the overlap matching, the problem is to "nail down" the parity of a location, since the pattern is shifted and compared to every text location. However, since the only property we have used in our grouping was the parity of the text location, it is clear that in all the pattern alignments that start in odd locations, the parity of the $a$ occurrences will be the same. Similarly, these parities will be the same for all pattern alignments that start in even text locations. Thus, we define $P_{o d d-a}$ and $P_{\text {even }-a}$ in the same way we defined $T_{o d d-a}$ and $T_{\text {even-a }}$. The following lemma shows how to utilize the reduction to overlap matching and follows directly from the discussion.

Lemma $3 P$ swap matches at an odd location, $2 i+1$, of $T$ iff $P_{\text {odd-a }}$ overlap matches $T_{\text {even-a }}$ at location $2 i+1$ and $P_{\text {even-a }}$ overlap matches $T_{\text {odd-a }}$ at location $2 i+1$.
$P$ swap matches at an even location, $2 i$, of $T$ iff $P_{\text {odd-a }}$ overlap matches $T_{\text {odd-a }}$ at location $2 i$ and $P_{\text {even-a }}$ overlap matches $T_{\text {even-a }}$ at location $2 i$.

Therefore, for swap matching we can state the following.

Theorem 1 Swap Matching can be solved in $O(n \log m \log \sigma)$ for a general alphabet $\Sigma$, where $\sigma=\min (m,|\Sigma|)$.

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## $9 \quad$ Appendix

### 9.1 Completing the Odd-Even Even-Odd Segments Case

Solution 1. The first problem can be easily solved. The convolution below provides, for every text location $i$, the sum $\sum_{j}\left(k_{j}-2\right)$, where $k_{j}$ are all the overlap lengths. All that is necessary, then, is to subtract the result of this convolution from the value obtained for each text location.

The Overlap Length Convolution: Replace every segment of length $\ell$ in both text and pattern by $01^{\ell-2} 0$. Replace all $\phi$ 's by 0 's. Multiply.

Solution 2. The starting locations of all text segments are known in advance and thus the substitution of the segment by $s_{1} 1^{\ell_{t}-2}-s_{1}$ can be done in linear time for the entire text. The pattern segment is problematic since it has $n-m$ different alignments. Therefore, we treat the pattern segments as if they all start relative to location 1.

The Zero Containment Convolution: Replace every segment of length $\ell_{t}$ starting in location $s_{1}$ of the text by $s_{1} 1^{\ell_{t}-2}-s_{1}$. Replace every segment of length $\ell_{p}$ starting at location $s p_{1}$ of the pattern by $s p_{1} 1^{\ell_{p}-2}-s p_{1}$. Replace all $\phi$ 's by 0 's. Multiply.

The problem is that now the result of the multiplication of side overlaps (after subtraction of the overlap length convolution) may sometimes be positive and sometimes be negative. This may cause the zero containment convolution result to be a 0 even for overlaps that are not contained, i.e. of odd length. We will then not be able to distinguish between them and the cases of all overlaps being containments.

We now show how to adjust the zero containment convolution to give the desired result. The zero containment convolution (after subtracting the result of the overlap length convolution) causes all contained segments to give the result 0 . Thus in location $i_{0}$ we get the value

$$
\sum_{\ell \in A} s p_{\ell}-\sum_{k \in B} s p_{k}+\sum_{i \in C} s_{i}-\sum_{j \in D} s_{j}
$$

where $A$ is the the set of pattern segments that have text segments overlapping them from the left, $B$ is the the set of pattern segments that have text segments overlapping them from the right, $C$ is the set of text segments that have right overlap with pattern segments and $D$ is the set of text segments that have left overlap with pattern segments.

The problem is that the result we really want is

$$
\sum_{\ell \in A} s_{\ell}-\sum_{k \in B} s_{k}+\sum_{i \in C} s_{i}-\sum_{j \in D} s_{j}
$$

In other words, we want the starting positions of the aligned pattern segments, rather than their starting positions relative to location 1. However, note that for location $i_{0}, s_{x}=i_{0}+s p_{x}$. This means that the value we want in location $i_{0}$ is

$$
\sum_{\ell \in A}\left(s p_{\ell}+i_{0}\right)-\sum_{k \in B}\left(s p_{k}+i_{0}\right)+\sum_{i \in C} s_{i}-\sum_{j \in D} s_{j}
$$

This equals

$$
\sum_{\ell \in A} s p_{\ell}-\sum_{k \in B} s p_{k}+\sum_{i \in C} s_{i}-\sum_{j \in D} s_{j}+\sum_{\ell \in A} i_{0}-\sum_{k \in B} i_{0} .
$$

We conclude that the desired value will be obtained if we add to the result of the zero containment convolution at every location $i_{0}$ the value $\sum_{\ell \in A} i_{0}-\sum_{k \in B} i_{0}$. These values can be obtained by the following convolution.

The Shifting Convolution: Replace every pattern segment of length $\ell_{p}$ by $10^{\ell_{p}-2}-1$ and every text segment of length $\ell_{t}$ by $01^{\ell_{t}-2} 0$. Replace every $\phi$ by 0 . Multiply.

It is easy to see that the result of this convolution in location $i_{0}$ is $\sum_{\ell \in A} i_{0}-\sum_{k \in B} i_{0}$.
Definition: Let $T$ be a text with segments $S t_{1}, \ldots, S t_{x}$ starting at locations $s_{1}, \ldots, s_{x}$, respectively. Let $P$ be a pattern such that, when placed at location $i_{0}$, its segments $S p_{1}, \ldots, S p_{y}$ start at locations $v_{1}, \ldots, v_{y}$. Let $\left\{s_{i_{1}}, \ldots, s_{i_{z}}\right\}$ be the starting locations of text segments that have a left overlap with pattern segments, and let $\left\{v_{j_{1}}, \ldots, v_{j_{z}}\right\}$ be the starting location of the corresponding pattern segments. Similarly let $\left\{s_{k_{1}}, \ldots, s_{k_{w}}\right\}$ be the starting locations of text segments that have a right overlap with pattern segments, and $\left\{v_{\ell_{1}}, \ldots, v_{\ell_{w}}\right\}$ be the starting locations of the corresponding pattern segments.

The external side length of the pattern at location $i_{0}$ is

$$
\sum_{r=1}^{y}\left(v_{i_{r}}-s_{j_{r}}\right)+\sum_{r=1}^{z}\left(s_{k_{r}}-v_{\ell_{r}}\right) .
$$

Note that containments do not contribute to the external side length. See figure 8 for an illustration.


Figure 8: The sum of the shaded areas is the external side length:

$$
\left(v_{1}-s_{1}\right)+\left(v_{2}-s_{2}\right)+\left(v_{3}-s_{4}\right)+\left(s_{2}-v_{1}\right) .
$$

Note that we are not counting external lengths of containments.

Lemma 4 It is possible in time $O(n \log m)$ to provide, for every text location $i$, a value that is 0 if all overlaps of the pattern and text segments are containments, and positive otherwise.

Proof: Add the results of the shifting convolution and the zero containment convolution and subtract from it the result of the overlap length convolution. We get the external side length which is 0 if all overlaps are containments and positive, otherwise.

### 9.2 Proof of Lemma 2

Proof. First, we show the if part. For any overlap of segments that is of even length the overlapping portions of $A$ and $B$ can be made identical by swapping, if necessary. Note that these swaps stay within the overlapping portion so other segments are not affected. If the overlap is odd and the overlapping portions match exactly then nothing needs to be done. So clearly, if the pattern does not match it must be the case that there exists a segment $A$ in the text and a segment $B$ in the pattern that overlap with odd-length overlap and with misaligning characters in the overlap.

Consider the only if part now. Suppose $A$ and $B$ overlap such that the overlap is of odd length and, without loss of generality, the overlap has $u=(a b)^{*} a$ in the text and $v=(b a)^{*} b$ in the pattern. Then, for a match to occur, either the leftmost $b$ in $v$ must be swapped with the character to the left or the rightmost $b$ in $v$ must be swapped with the character to the right.

Clearly, the portion of $B$ overlapping $A$ cannot be a prefix of $B$ for the above swap to be effective (the character preceding $B$, if any, is a $b$ ). It follows that the portion of $B$ overlapping $A$ must be a prefix of $A$. Once again the above swap is ineffective (the character preceding $A$ is an $a$ ). Thus it follows that the pattern does not match at this alignment.

### 9.3 Reducing Large Alphabets to Binary Alphabets

In [2] it was shown how to reduce the swap matching problem over unbounded alphabets to the problem over a two letter alphabet with an $O\left(\log ^{2}|\Sigma|\right)$ multiplicative overhead. Here we outline a reduction requiring only an $O(\log |\Sigma|)$ factor detailed in [1]. Another unpublished $O(\log |\Sigma|)$ reduction appears in [9].

Definition: A $(\Sigma, 3)$-universal set is a set $S=\left\{\chi_{1}, \ldots, \chi_{k}\right\}$ of characteristic functions, $\chi_{j}: \Sigma \rightarrow$ $\{0,1\}$ such that for every $a, b, c \in \Sigma$, and for each of the eight possible combinations of $0-1 \mathrm{~s}$, there exists $\chi_{j}$ such that $\chi_{j}(a), \chi_{j}(b), \chi_{j}(c)$ equals this combination.
We extend the definition of the functions $\chi_{j}$ to strings in the usual manner, i.e. for $S=s_{1} \ldots s_{n}$, $\chi_{j}(S)=\chi_{j}\left(s_{1}\right) \chi_{j}\left(s_{2}\right) \ldots \chi_{j}\left(s_{n}\right)$.

Theorem 2 [2] Let $P$ be a pattern, $T$ a text, both over an arbitrary alphabet $\Sigma$, and let $S=$ $\left\{\chi_{1}, \ldots, \chi_{k}\right\}$ be a $(\Sigma, 3)$-universal set. $P$ swap matches $T$ at location $i$ iff for all $j, \chi_{j}(P)$ swap matches $\chi_{j}(T)$ at location $i$.

In [23] it was shown how to construct a $(\Sigma, 3)$-universal set of cardinality $k=O(\log |\Sigma|)$ yielding the following.

Corollary $1 A$ solution of the Swap Matching problem over alphabet $\{a, b\}$ of time $O(f(n, m))$ implies a solution of time $O(\log |\Sigma| f(n, m))$ over a general alphabet $\Sigma$.


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